

AC CONDUCTANCE AND NON-SYMMETRIZED NOISE AT FINITE FREQUENCY IN QUANTUM WIRE AND CARBON NANOTUBE

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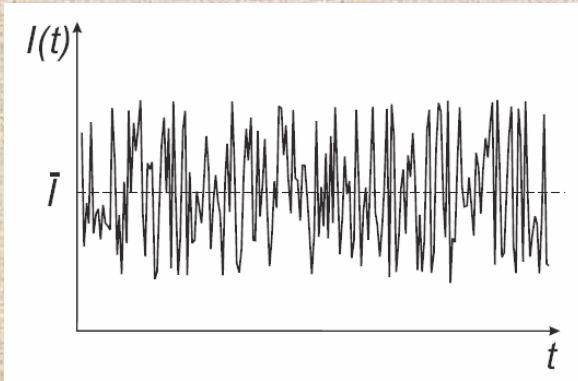
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CURRENT FLUCTUATIONS



ORIGINS OF NOISE

- High temperature : Johnson-Nyquist noise
- High voltage : Shot noise
- High frequency : Quantum noise
- We neglect the 1/f noise

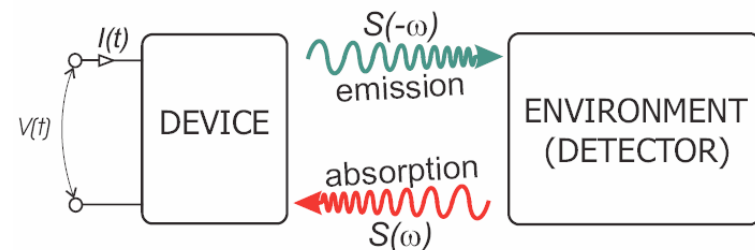
ZERO FREQUENCY AND ZERO TEMPERATURE: SHOT NOISE

⇒ Schottky relation $S^+(\omega=0) = e * |\langle \delta j \rangle|$ where $S^+(\omega) = FT \left\{ \frac{1}{2} [\langle \delta j(0) \delta j(t) \rangle + \langle \delta j(t) \delta j(0) \rangle] \right\}$
symmetrized noise

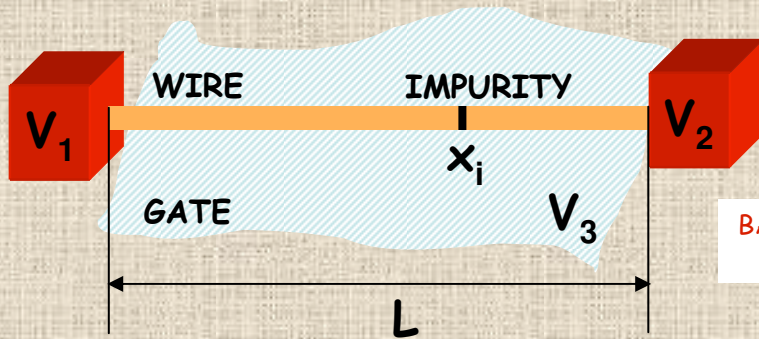
HIGH FREQUENCY NOISE MEASUREMENTS

- High-frequency measurement in a diffusive wire 1 – 20GHz SCHOELKOPF et al., PRL (1997)
- On-chip detection using SIS junction → 100 GHz DEBLOCK et al., Science (2003)
- Direct measurement in a QPC 4 – 8GHz ZAKKA-BAJJANI et al., PRL (2007)

What is measured is $S(\omega) = \int dt e^{i\omega t} \langle \delta j(0) \delta j(t) \rangle$
non-symmetrized noise



THE SYSTEM



MODEL

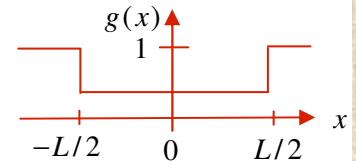
$$H = H_0 + H_B + H_V$$

$$H_0 = \frac{\hbar v_F}{2} \int_{-\infty}^{\infty} dx \left[\Pi^2 + \frac{1}{g^2(x)} (\partial_x \Phi)^2 \right]$$

$$H_B = \lambda \cos \left[\sqrt{4\pi} \Phi(x_i, t) + 2k_F x_i \right]$$

$$H_V = - \int_{-\infty}^{\infty} \frac{dx}{\sqrt{\pi}} eV(x) \partial_x \Phi(x, t)$$

COULOMB INTERACTIONS PARAMETER



BACKSCATTERING AMPLITUDE

WE CALCULATE PERTURBATIVELY

□ The non-symmetrized noise: $S_{nm}(\omega) = \int dt e^{i\omega t} \langle \delta j_m(0) \delta j_n(t) \rangle$ where $n, m = 1, 2, 3$

□ The AC conductance: $G_{nm}(t-t') = \frac{\delta I_n(t)}{\delta V_m(t')} \Big|_{V_m=0}$ where $\begin{cases} \delta I_n(t) = \langle \delta j_n(t) \rangle \\ V_n(t) = v_n \cos(\omega t) \end{cases}$

RESULT

$$S_{nm}(\omega) = S_{nm}^+(\omega) - \hbar \omega \text{Re}[G_{nm}(\omega)]$$

with $S_{nm}^+(\omega) = \frac{1}{2} \int dt e^{i\omega t} \langle \langle \delta j_m(0) \delta j_n(t) + \delta j_m(t) \delta j_n(0) \rangle \rangle$ **symmetrized noise**

GENERALIZED KUBO-TYPE FORMULA

$$S_{nm}^-(\omega) = S_{nm}(\omega) - S_{nm}(-\omega) = -2\hbar \omega \text{Re}[G_{nm}(\omega)]$$

SAFI AND SUKHORUKOV (unpublished)

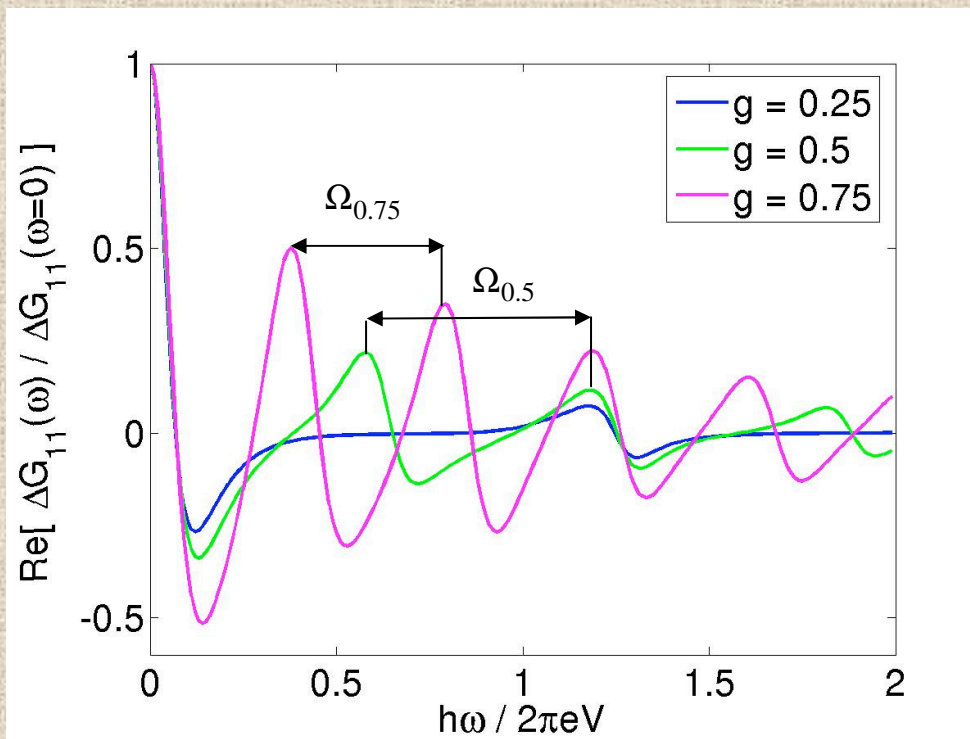
AC CONDUCTANCE

WEAK-BACKSCATTERING LIMIT OF THE EXCESS AC CONDUCTANCE

$$\Delta G_{11}(\omega) = G_{11}(\omega) - G_{11}(\omega)|_{V=0} \quad \text{where} \quad V = V_2 - V_1 \quad \text{source-drain voltage}$$

FOR $g=1$: $\Delta G_{11}(\omega) = 0$ *because of the linearity of the I-V characteristic*

FOR $g \neq 1$: *oscillations with frequency with a pseudo-period related to the wire frequency* $\omega_L = v_F / gL$



$$\begin{aligned} x_i &= 0 \\ T &= 0 \\ \lambda / eV &= 0.01 \\ g\hbar\omega_L / eV &= 0.05 \end{aligned}$$

The pseudo-period depends on L and g :

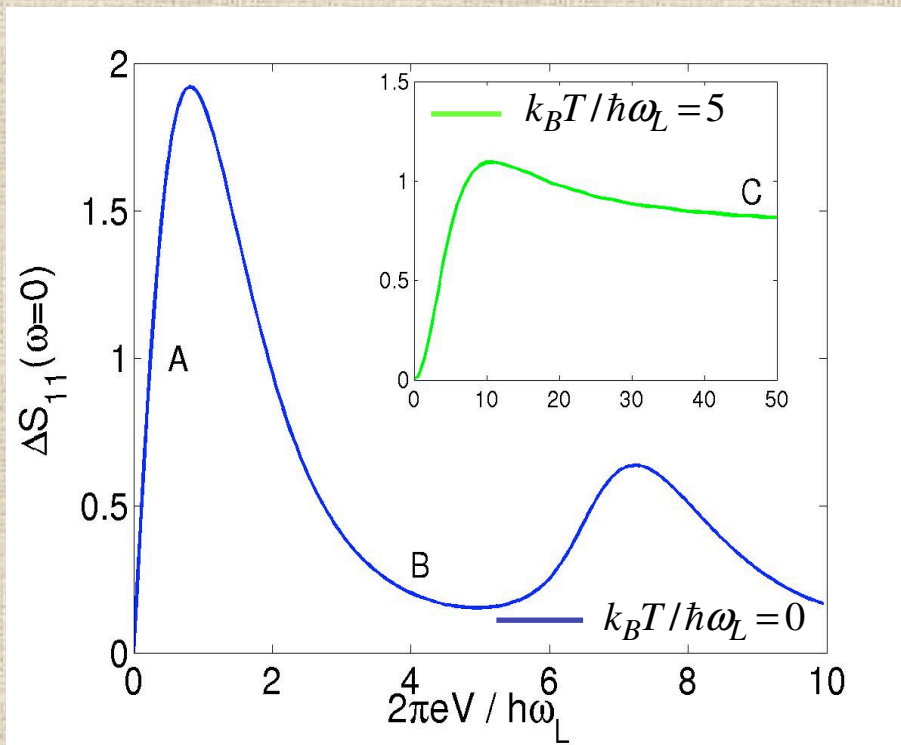
$$\Omega_g = \frac{hv_F}{gL eV}$$

ZERO-FREQUENCY NOISE

IN THE WEAK-BACKSCATTERING LIMIT

$$S_{nm}(\omega=0) = eI_B \coth\left(\frac{eV}{2k_B T}\right) + 2k_B T \left[\frac{e^2}{h} - 2 \frac{\partial I_B}{\partial V} \right]$$

where I_B is the backscattering current



- **REGION A:** short-wire limit $eV < \hbar\omega_L$
 \Rightarrow **linear variation** with voltage
 \Rightarrow qualitative agreement with experiments on carbon nanotubes

WU et al., PRL 99, 156803 (2007)
HERRMANN et al., PRL 99, 156804 (2007)

- **REGION B:** long-wire limit $eV > \hbar\omega_L$
 \Rightarrow **oscillations** whose envelope has a power-law dependence

- **REGION C:** high temperature limit
 $k_B T > \hbar\omega_L$

\Rightarrow behaves like the noise of an infinite length interacting wire: **power-law variation**

FINITE-FREQUENCY NON-SYMMETRIZED NOISE

WE CALCULATE

$$\Delta S_{nm}(\omega) = S_{nm}(\omega) - S_{nm}(\omega)|_{V=0}$$

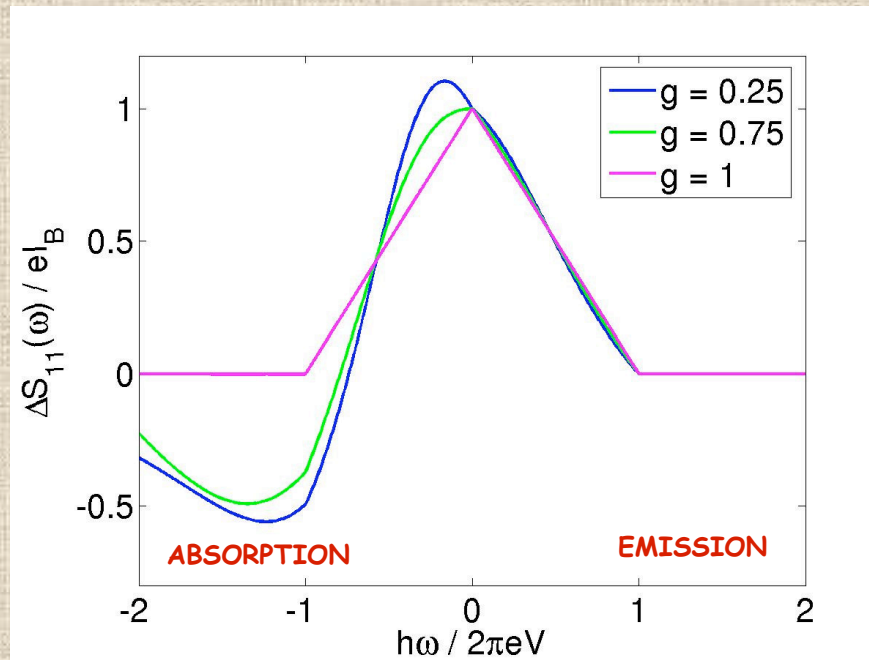
FOR $g=1$: the non-symmetrized excess noise is **symmetric**

$$S_{nm}(\omega) = S_{nm}^+(\omega) - \hbar\omega \text{Re}[G_{nm}(\omega)] \Rightarrow \Delta S_{nm}(\omega) = \Delta S_{nm}^+(\omega) \quad \text{because} \quad \Delta G_{11}(\omega) = 0 \quad \text{when} \quad g = 1$$

FOR $g \neq 1$: the non-symmetrized excess noise becomes **asymmetric**

SHORT-WIRE LIMIT

$$g\hbar\omega_L / eV = 1$$



$$x_i = 0$$

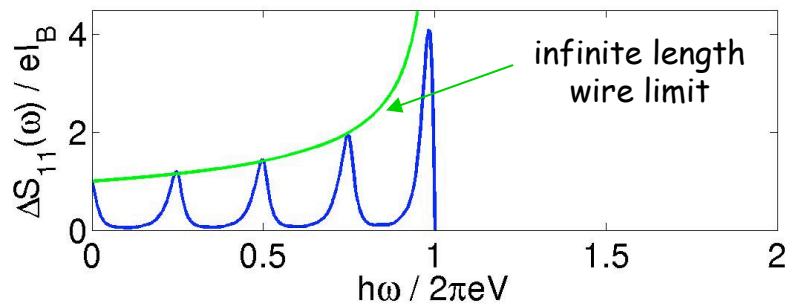
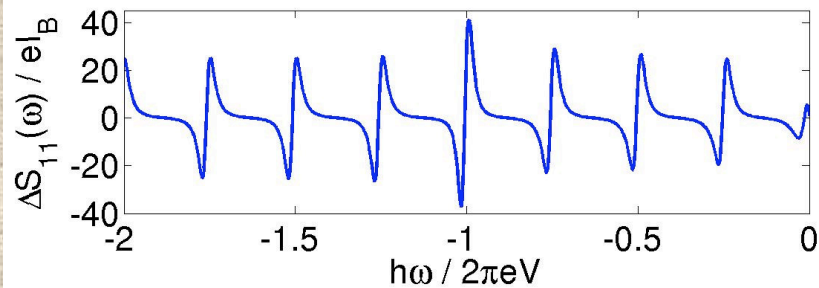
$$T = 0$$

$$\lambda / eV = 0.01$$

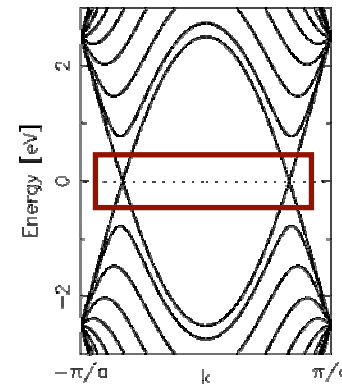
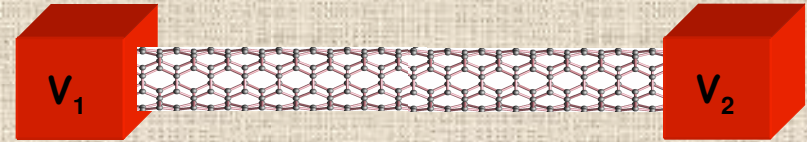
FINITE-FREQUENCY NON-SYMMETRIZED NOISE

LONG-WIRE LIMIT

$g = 0.25$
 $x_i = 0$
 $T = 0$
 $\lambda / eV = 0.01$
 $g\hbar\omega_L / eV = 0.01$

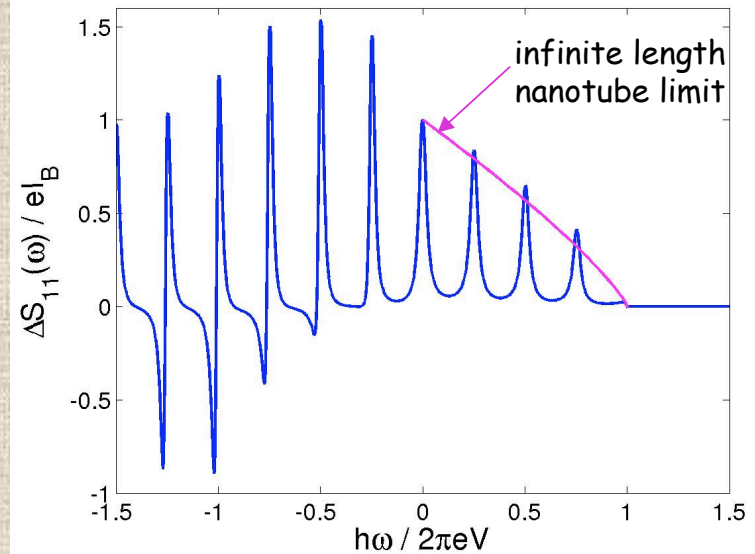


CARBON NANOTUBE



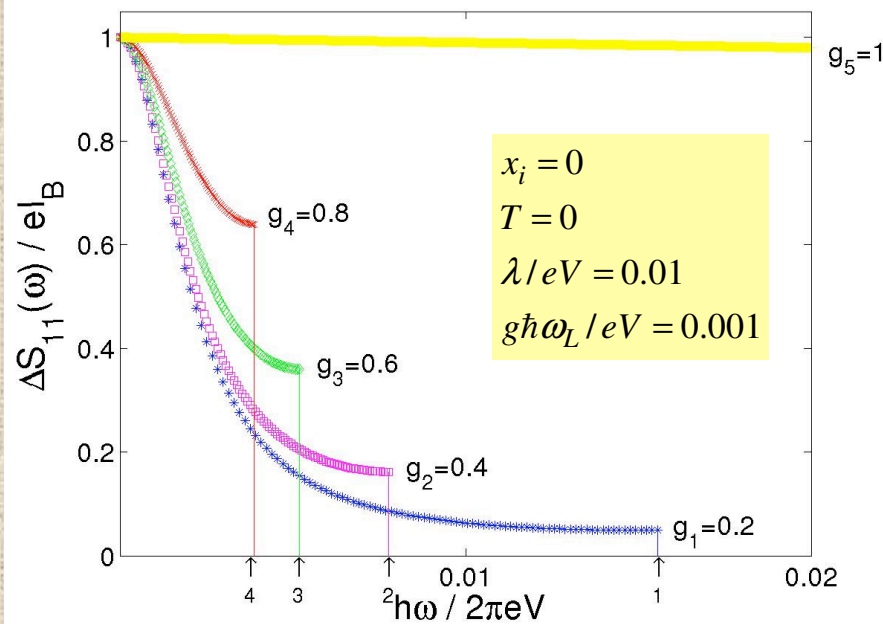
**four channels
of conduction**

{ charge sector with $g < 1$
 { 3 others sectors with $g = 1$

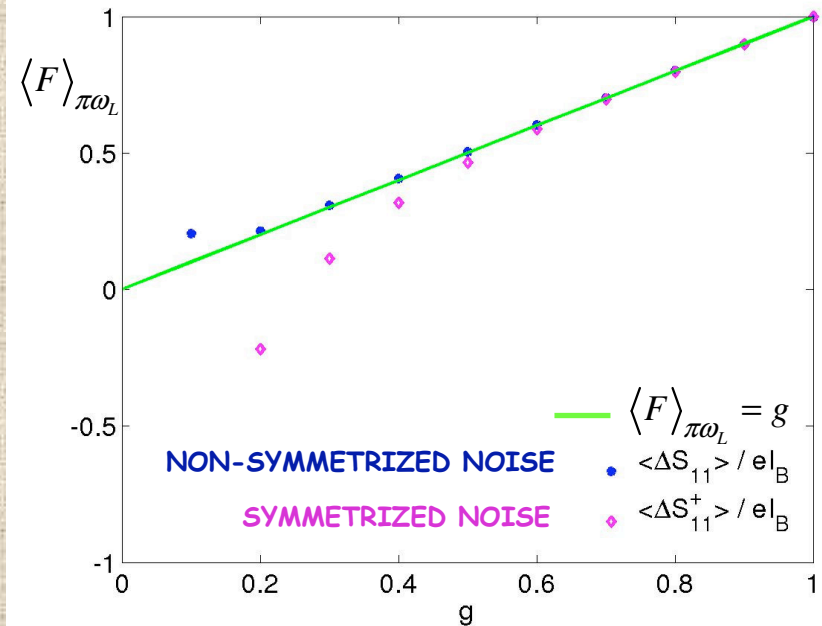


AVERAGE NON-SYMMETRIZED NOISE

EMISSION EXCESS NOISE



AVERAGED FANO FACTOR



WE CALCULATE THE AVERAGE OVER THE FIRST HALF PERIOD

$$\langle F \rangle_{\pi\omega_L} = \frac{\langle \Delta S_{11}(\omega) \rangle_{\pi\omega_L}}{eI_B} \quad \text{where} \quad \langle \Delta S_{11}(\omega) \rangle_{\pi\omega_L} = \frac{1}{\pi\omega_L} \int_0^{\pi\omega_L} \Delta S_{11}(\omega) d\omega$$

$$\Rightarrow \text{we obtain } \boxed{\langle F \rangle_{\pi\omega_L} \approx g}$$

\Rightarrow it should be possible to extract the value of the interaction parameter g

CONCLUSION

- **Simple relation** between the AC conductance the non-symmetrized noise

$$S_{nm}(\omega) = S_{nm}^+(\omega) - \hbar\omega \text{Re}[G_{nm}(\omega)]$$

- In the presence of Coulomb interactions, the non-symmetrized noise is asymmetric:

Emission noise ($\omega > 0$) \neq Absorption noise ($\omega < 0$)

- At low-temperature and for a long wire or a long nanotube, we obtain **oscillations** with a period related to L and g
- The **average non-symmetrized excess noise** over the first half period gives the value of g

$$\frac{\langle \Delta S_{11}(\omega) \rangle_{\pi\omega_L}}{eI_B} \approx g$$

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